Notice of References Cited

Application/Control No. 10/583,534	Applicant(s)/Pater Reexamination LI ET AL.	nt Under
Examiner	Art Unit	
MARIA L. SEKUL	2461	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2002/0018527	02-2002	Vanderaar et al.	375/259
*	В	US-7,376,424	05-2008	Kim et al.	455/436
	С	US-			
	D	US-			
	Е	US-			
	F	US-			
	G	US-		-	
	Н	US-			
	_	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

	FOREIGN PATENT DOCUMENTS					
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	s					
	Т					

NON DATENT DOCUMENTS

_	NON-PATENT DOCUMENTS			
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)		
	U			
	v			
	w			
	x			

A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.